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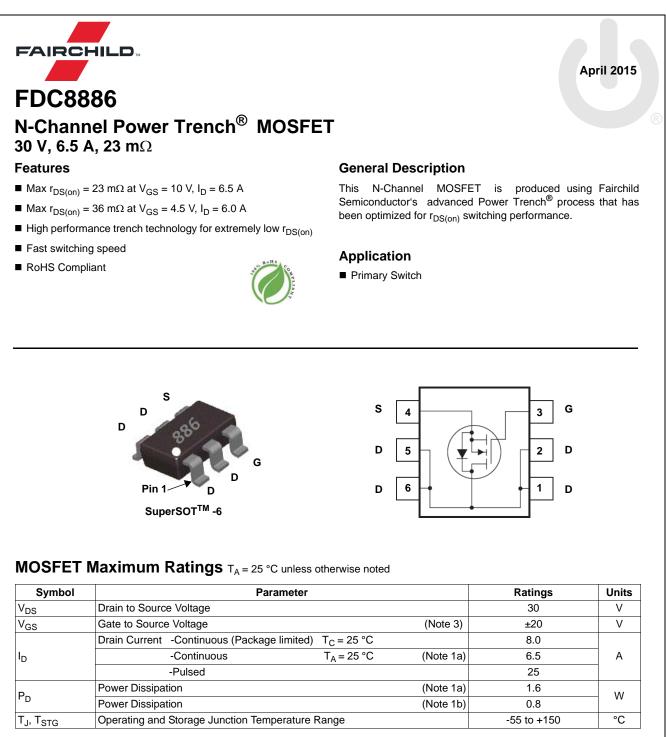


# **ON Semiconductor**®

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Please note: As part of the Fairchild Semiconductor integration, some of the Fairchild orderable part numbers will need to change in order to meet ON Semiconductor's system requirements. Since the ON Semiconductor product management systems do not have the ability to manage part nomenclature that utilizes an underscore (\_), the underscore (\_) in the Fairchild part numbers will be changed to a dash (-). This document may contain device numbers with an underscore (\_). Please check the ON Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at <a href="mailto:www.onsemi.com">www.onsemi.com</a>. Please email any questions regarding the system integration to <a href="mailto:Fairchild\_questions@onsemi.com">Fairchild\_questions@onsemi.com</a>.

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### **Thermal Characteristics**

| $R_{	ext{	heta}JC}$ | Thermal Resistance, Junction to Case              | 30 | °C/W |
|---------------------|---|----|------|
| $R_{	ext{	heta}JA}$ | Thermal Resistance, Junction to Ambient (Note 1a) | 78 | C/VV |

## **Package Marking and Ordering Information**

| Device Marking | Device  | Package | Reel Size | Tape Width | Quantity   |
|----------------|---------|---------|-----------|------------|------------|
| .886           | FDC8886 | SSOT-6  | 7 "       | 8 mm       | 3000 units |

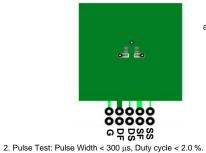
FDC8886 N-Channel Power Trench<sup>®</sup> MOSFET

| Symbol                                 | Parameter   | Test Conditions  | Min | Тур  | Max | Units |  |
|--|---|--|-----|------|-----|-------|--|
| Off Chara                              | octeristics   |  |     |      |     |       |  |
| BV <sub>DSS</sub>                      | Drain to Source Breakdown Voltage                           | $I_D = 250 \ \mu A, \ V_{GS} = 0 \ V$  | 30  |      |     | V     |  |
| $\frac{\Delta BV_{DSS}}{\Delta T_{J}}$ | Breakdown Voltage Temperature<br>Coefficient                | $I_D = 250 \ \mu\text{A}$ , referenced to 25 °C  |     | 18   |     | mV/°C |  |
| I <sub>DSS</sub>                       | Zero Gate Voltage Drain Current                             | $V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$  |     |      | 1   | μA    |  |
| I <sub>GSS</sub>                       | Gate to Source Leakage Current, Forward                     | $V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$  |     |      | 100 | nA    |  |
| On Chara                               | cteristics  |  |     |      |     |       |  |
| V <sub>GS(th)</sub>                    | Gate to Source Threshold Voltage                            | $V_{GS} = V_{DS}, I_{D} = 250 \ \mu A$   | 1.2 | 1.9  | 3.0 | V     |  |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage<br>Temperature Coefficient | $I_D = 250 \ \mu\text{A}$ , referenced to 25 °C  |     | -6   |     | mV/°C |  |
|  |   | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 6.5 A   |     | 19   | 23  | -     |  |
| r <sub>DS(on)</sub>                    | Static Drain to Source On Resistance                        | $V_{GS} = 4.5 \text{ V}, I_D = 6.0 \text{ A}$  |     | 30   | 36  | mΩ    |  |
|  |   | $V_{GS} = 10 \text{ V}, \ \text{I}_{D} = 6.5 \text{ A}, \ \text{T}_{J} = 125 \ ^{\circ}\text{C}$ |     | 25   | 30  | 7     |  |
| 9 <sub>FS</sub>                        | Forward Transconductance                                    | $V_{DD} = 5 \text{ V}, \ \text{I}_{D} = 6.5 \text{ A}$   |     | 24   |     | S     |  |
| Dynamic                                | Characteristics   |  |     |      |     |       |  |
| C <sub>iss</sub>                       | Input Capacitance   | X 45.X.X. 0.Y.   |     | 348  | 465 | pF    |  |
| C <sub>oss</sub>                       | Output Capacitance  | V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V,<br>f = 1 MHz                                      |     | 135  | 180 | pF    |  |
| C <sub>rss</sub>                       | Reverse Transfer Capacitance                                |  |     | 16   | 25  | pF    |  |
| R <sub>g</sub>                         | Gate Resistance   |  |     | 1.2  |     | Ω     |  |
| Switching                              | g Characteristics   |  |     |      |     |       |  |
| t <sub>d(on)</sub>                     | Turn-On Delay Time  |  |     | 5    | 10  | ns    |  |
| t <sub>r</sub>                         | Rise Time   | V <sub>DD</sub> = 15 V, I <sub>D</sub> = 6.5 A,  |     | 1    | 10  | ns    |  |
| t <sub>d(off)</sub>                    | Turn-Off Delay Time   | $V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$  |     | 11   | 19  | ns    |  |
| t <sub>f</sub>                         | Fall Time   |  |     | 1    | 10  | ns    |  |
| 0                                      | Total Gate Charge   | $V_{GS} = 0 V$ to 10 V   |     | 5.3  | 7.4 | nC    |  |
| Q <sub>g(TOT)</sub>                    | Total Gate Charge   | $V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 15 \text{ V}$                                 |     | 2.5  | 3.5 | nC    |  |
| Q <sub>gs</sub>                        | Total Gate Charge   | I <sub>D</sub> = 6.5 A   |     | 1.0  |     | nC    |  |
| Q <sub>gd</sub>                        | Gate to Drain "Miller" Charge                               |  |     | 0.8  |     | nC    |  |
| Drain-Soເ                              | urce Diode Characteristics                                  |  |     |      |     |       |  |
| V <sub>SD</sub>                        | Source to Drain Diode Forward Voltage                       | $V_{GS} = 0 V, I_S = 6.5 A$ (Note 2)   |     | 0.86 | 1.2 | V     |  |
| t <sub>rr</sub>                        | Reverse Recovery Time                                       | I <sub>F</sub> = 6.5 A, di/dt = 100 A/μs   |     | 14   | 22  | ns    |  |
| Qrr                                    | Reverse Recovery Charge                                     | $F = 0.5 A, u/ul = 100 A/\mu S$  |     | 3    | 10  | nC    |  |

Q<sub>rr</sub>

NOTES:

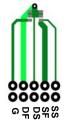
 $R_{0,L}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{0,L}$  is guaranteed by design while  $R_{0,CA}$  is determined by the user's board design.



Reverse Recovery Charge

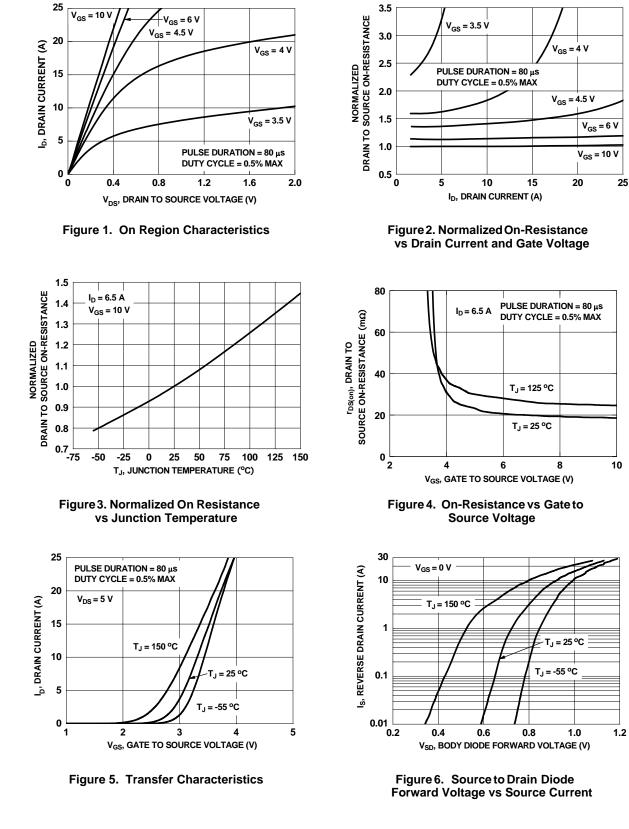
a. 78 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper

3. As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.



b.175 °C/W when mounted on a minimum pad of 2 oz copper

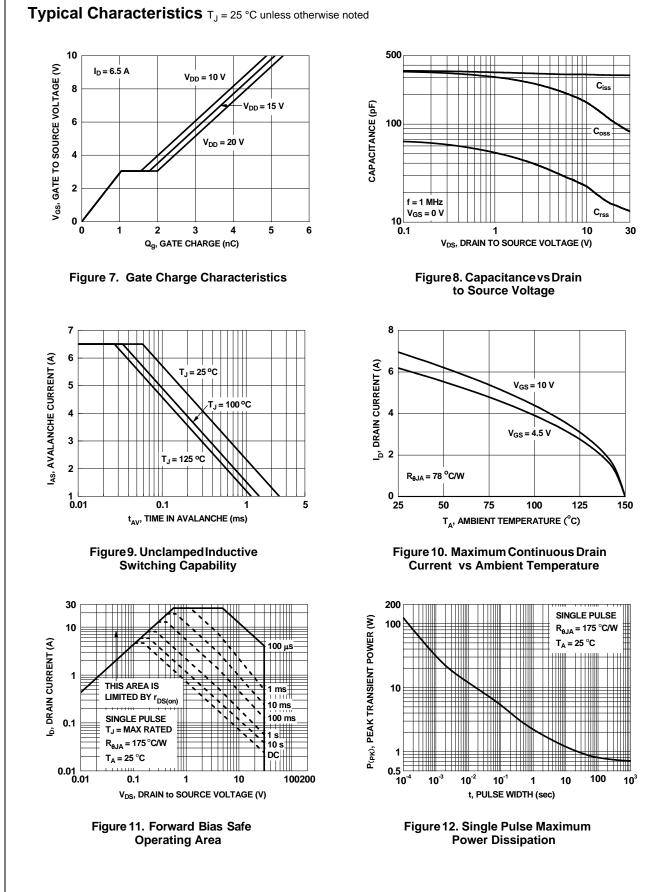
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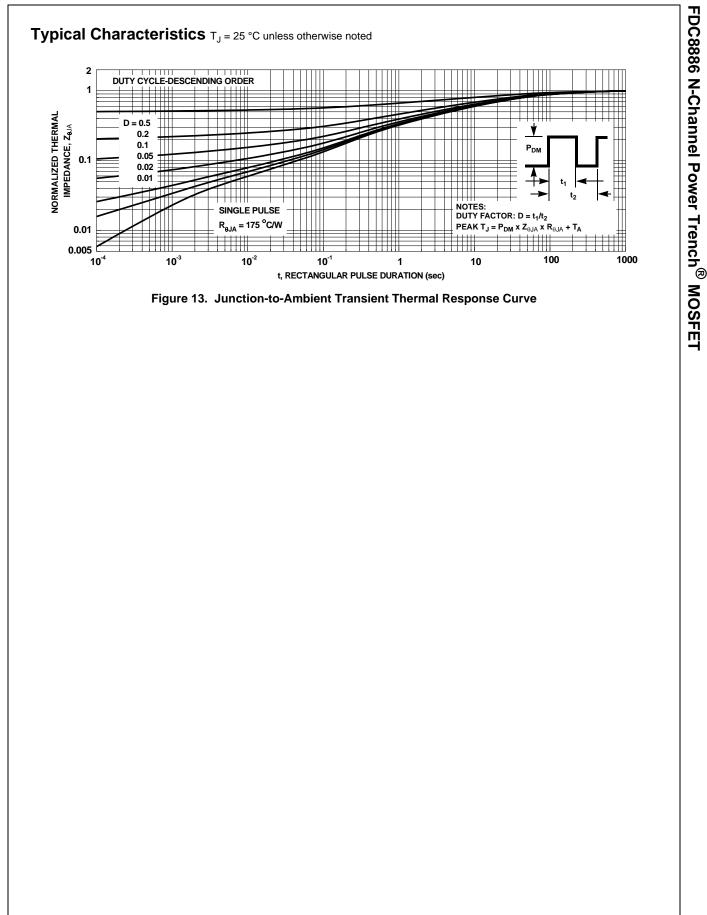
# Typical Characteristics T<sub>J</sub> = 25 °C unless otherwise noted

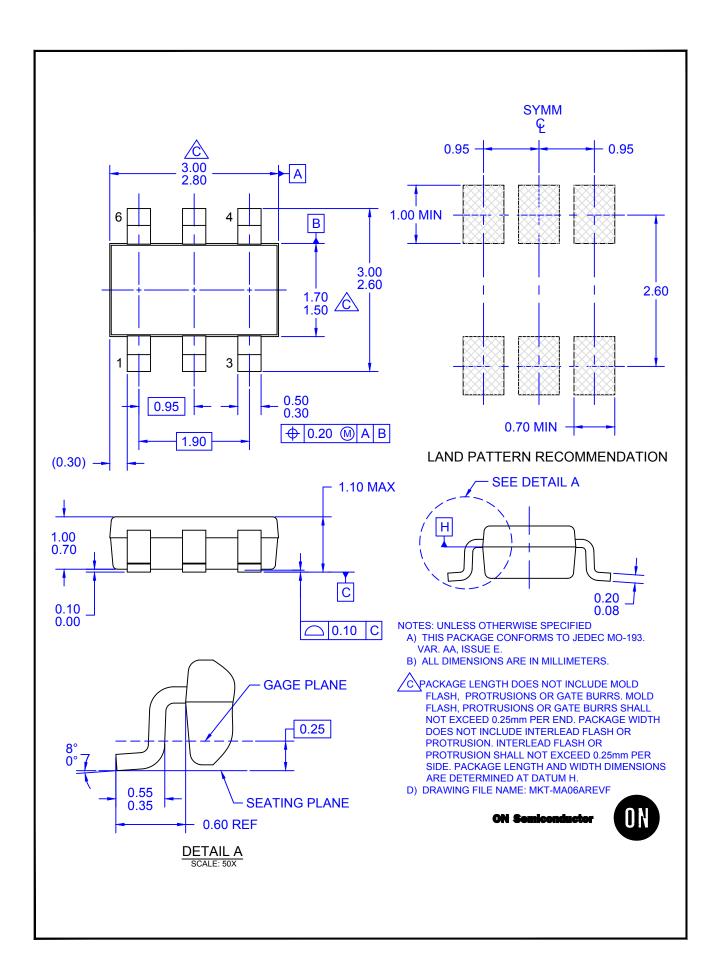
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